

Notice of References Cited	Application/Control No. 10/032,885	Applicant(s)/Patent Under Reexamination LI ET AL.	
	Examiner Sargon N. Nano	Art Unit 2157	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,099,028	08-2006	Schneider et al.	358/1.15
*	B	US-6,952,780	10-2005	Olsen et al.	726/26
*	C	US-6,700,891	03-2004	Wong, Dean W.	370/401
*	D	US-6,216,113	04-2001	Aikens et al.	705/34
*	E	US-2002/0097419	07-2002	Chang et al.	358/1.13
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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